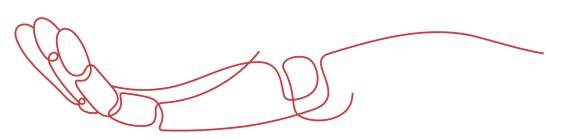




# **PRODUCT DATA SHEET**



To learn more about JGSEMI, please visit our website at







Datasheet

ources Samples

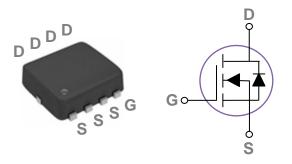
Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO\_questions@jgsemi.com.



## **General Description**

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

PPAK3X3



BVDSS	RDSON	ID
30V	7.9m $\Omega$	45A

#### **Features**

- 30V,45A, RDS(ON) =7.9mΩ@VGS = 10V
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

# **Applications**

- Networking
- Load Switch
- LED applications

# Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	30	V
V <sub>G</sub> s	Gate-Source Voltage	±20	V
1_	Drain Current – Continuous (T <sub>C</sub> =25°C)	45	А
lD	Drain Current – Continuous (T <sub>C</sub> =100°C)	28.5	А
I <sub>DM</sub>	Drain Current – Pulsed <sup>1</sup>	180	А
EAS	Single Pulse Avalanche Energy <sup>2</sup>	45	mJ
IAS	Single Pulse Avalanche Current <sup>2</sup>	30	А
В	Power Dissipation (T <sub>C</sub> =25°C)	30	W
P <sub>D</sub>	Power Dissipation – Derate above 25°C	0.24	W/°C
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

## **Thermal Characteristics**

Symbol	ol Parameter		Max.	Unit
R <sub>0JA</sub>	Thermal Resistance Junction to ambient		62	°C/W
Rejc	Thermal Resistance Junction to Case		4.15	°C/W



# **Electrical Characteristics** (T<sub>J</sub>=25 °C, unless otherwise noted)

#### **Off Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	30			V
I	Drain-Source Leakage Current	V <sub>DS</sub> =30V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	uA
IDSS	Diam-Source Leakage Current	V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =125°C			10	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±100	nA

### **On Characteristics**

R <sub>DS(ON)</sub>	RDS(ON) Static Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =15A		6.6	7.9	mΩ
NDS(ON)	Static Dialii-Source Off-Nesistance	V <sub>GS</sub> =4.5V , I <sub>D</sub> =10A		9.2	12	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	1.2	1.6	2.5	V
gfs	Forward Transconductance	V <sub>DS</sub> =10V , I <sub>D</sub> =3A		20		S

## **Dynamic and switching Characteristics**

Qg	Total Gate Charge <sup>3, 4</sup>		 15	23	
$Q_gs$	Gate-Source Charge <sup>3, 4</sup>	V <sub>DS</sub> =15V , V <sub>GS</sub> =10V , I <sub>D</sub> =25A	 1.8	3	nC
$Q_{gd}$	Gate-Drain Charge <sup>3,4</sup>		 4	6	
$T_{d(on)}$	Turn-On Delay Time <sup>3, 4</sup>		 5	7.5	
Tr	Rise Time <sup>3, 4</sup>	$V_{DD}$ =15 $V$ , $V_{GS}$ =10 $V$ , $R_{G}$ =6 $\Omega$	 13	20	20
$T_{d(off)}$	Turn-Off Delay Time <sup>3, 4</sup>	I <sub>D</sub> =25A	 28	42	ns
$T_f$	Fall Time <sup>3, 4</sup>		 8	12	
Ciss	Input Capacitance		 900	1350	
Coss	Output Capacitance	V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , F=1MHz	 130	200	pF
Crss	Reverse Transfer Capacitance		 110	170	
Rg	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=1MHz	 2		Ω

## **Drain-Source Diode Characteristics and Maximum Ratings**

Symbol	Parameter	er Conditions		Тур.	Max.	Unit
Is	Continuous Source Current	V- V- OV Force Current			45	Α
I <sub>SM</sub>	Pulsed Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			90	Α
$V_{SD}$	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C			1	V

#### Note:

- 1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2.  $V_{DD}=25V$ ,  $V_{GS}=10V$ , L=0.1 mH,  $I_{AS}=30$ A.,  $R_{G}=25\Omega$ ,  $Starting T_{J}=25^{\circ}C$ .
- 3. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%.
- 4. Essentially independent of operating temperature.

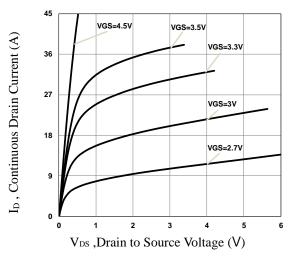


Fig.1 Typical Output Characteristics

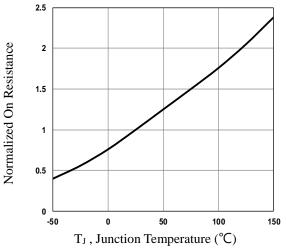


Fig.3 Normalized RDSON vs. T<sub>J</sub>

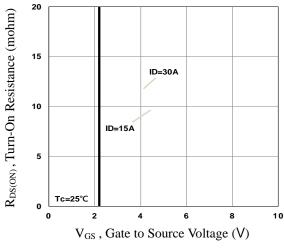


Fig.5 Turn-On Resistance vs. V<sub>GS</sub>

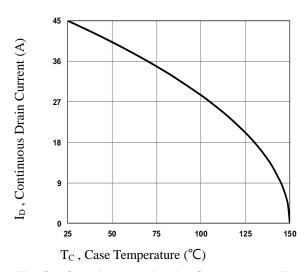


Fig.2 Continuous Drain Current vs. Tc

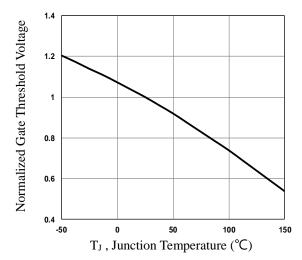


Fig.4 Normalized V<sub>th</sub> vs. T<sub>J</sub>

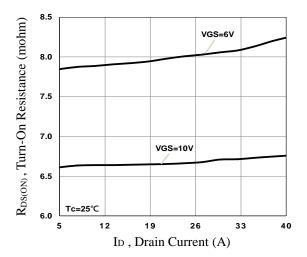
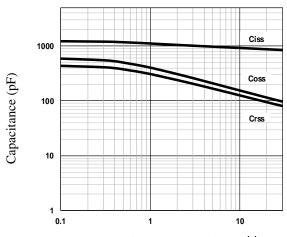


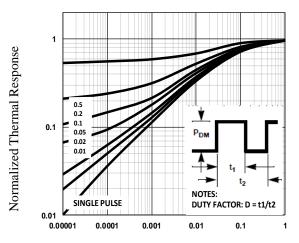
Fig.6 Turn-On Resistance vs. ID





 $V_{DS}$  , Drain to Source Voltage  $\left(V\right)$ 

Fig.7 Capacitance Characteristics



Square Wave Pulse Duration (s)

Fig.9 Normalized Transient Impedance

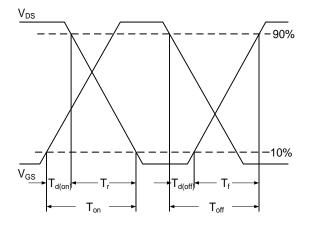


Fig.11 Switching Time Waveform

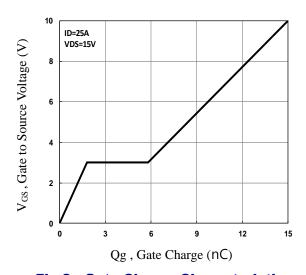
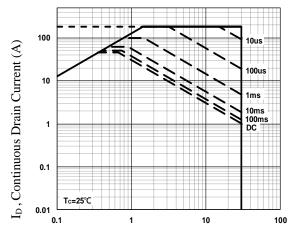


Fig.8 Gate Charge Characteristics



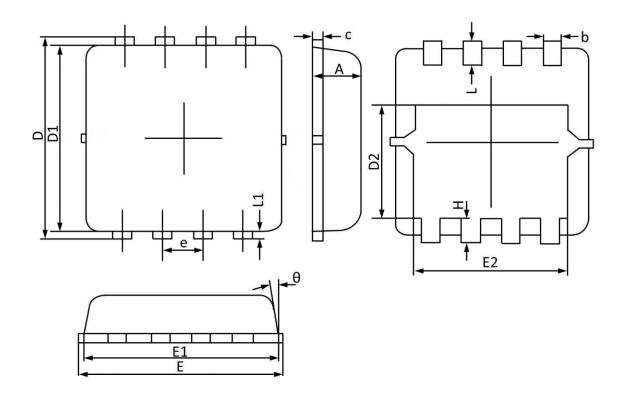
V<sub>DS</sub> , Drain to Source Voltage (V)

Fig.10 Maximum Safe Operation Area

Fig.12 EAS Waveform



# PPAK3x3 PACKAGE INFORMATION



Symbol	Dimensions In Millimeters			s In Inches
Symbol	MAX	MIN	MAX	MIN
Α	0.900	0.700	0.035	0.028
b	0.350	0.250	0.014	0.010
С	0.250	0.100	0.010	0.004
D	3.500	3.050	0.138	0.120
D1	3.200	2.900	0.126	0.114
D2	1.950	1.350	0.077	0.053
E	3.400	3.000	0.134	0.118
E1	3.300	2.900	0.130	0.114
E2	2.600	2.350	0.102	0.093
е	0.65	BSC	0.02	6BSC
Н	0.750	0.300	0.030	0.012
L	0.600	0.300	0.024	0.012
L1	0.200	0.060	0.008	0.002
θ	14°	6°	14°	6°



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